

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/566,280	WANG ET AL.	
Examiner		Art Unit		Page 1 of 1
RIP A. LEE		1796		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0216019	09-2006	Thompson, Robert Lee	396/427
*	B	US-4,607,074	08-1986	Hazelton et al.	524/425
*	C	US-5,349,005	09-1994	Tanaka, Terutaka	524/490
*	D	US-2005/0215717	09-2005	Dozeman, Albertus O.	525/192
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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